Advancing with Technology ElektroPhysik

Coating thickness measurement



MiniTest 3100

Measurement of

- non-magnetic coatings (e.g. paint, zinc) on steel
- insulating coatings (e.g. paint, anodising coatings) on non-ferrous metals
- non-ferrous metal coatings on insulating substrates

Wear-resistant probes for multi-purpose use High accuracy and reproducibility Storage and documentation of readings

Coating thickness measurement with MiniTest

For more than 60 years now, ElektroPhysik has developed and produced an extensive range of precision measuring instruments for surface treatment. Being a pioneer in the field of non-destructive coating thickness measurement, ElektroPhysik in cooperation with national and international standardising bodies, research institutes and universities has successfully advanced the worldwide standardisation of coating thickness measurement. Numerous patents underline ElektroPhysik's position as a leading manufacturer.

MiniTest 3100

Application

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The MiniTest gauge is a small universal gauge designed for non-destructive coating thickness measurement. For many years, automotive, shipbuilding, aircraft and machine manufacturers as well as government departments, inspectors, consultants and the paint and electroplating industry have used ElektroPhysik coating thickness gauges. Well-known automotive producers and leading manufacturers of nearly all branches of industry entrust ElektroPhysik gauges with their quality assurance.

Description

The MiniTest 3100 offers different possibilities of processing of measuring values. Different probes are available which can be connected. In order to select the "right" probe, the thickness of the coating to be measured as well as that of the substrate and the geometry have to be taken into consideration. ElektroPhysik offers a range of probes suitable for standard as well as for special applications. For measurements on steel, the magnetic induction principle is used allowing measurement of all insulating coatings, e.g. paint, enamel etc., and non-ferrous metals on steel and ferrous metals. Probes working on the magnetic induction principle are referred to as F-probes. For measurements of insulating coatings on non-ferrous metals, the eddy current principle is used. Probes working on this principle are referred to as N-probes.

Technical data

- All probes can be connected
- RS 232 interface for portable data printer MiniPrint 4100 or PC
- Calibration with one or two foils

MiniTest 3100 possesses a total memory capacity of 10,000 readings and the possibility to store readings in 10 application memories with 10 batches each. A calibration once performed remains in the application memory. Statistical evaluation of a measuring series allows the user to assess the coating with mean value, max., min., standard deviation and number of readings taken within one measuring series.

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DIN EN ISO 9000 ff./QS 9000/ISO/IEC 17025 (Guide 25)

Documentation and data analysis according to DIN EN ISO 9000 ff./QS 9000/ISO/IEC 17025 (Guide 25) requires to meet strictly defined rules and standards.

Therefore, when choosing a gauge for measuring coating thickness, in addition to evaluating the gauge's processing capabilities, consideration specifically to its high resolution and reproducibility capabilities should be focused on as well.

ElektroPhysik's MiniTest 3100 coating thickness testing gauge provides both high resolution (up to 0.1 microns/ 0.01 mils in the 1...100 microns/0...10 mils thickness range), as well as application-oriented memory capabilities with comprehensive statistical calculations of a series of measurements.

MiniTest standard probes - special probes

The probe is the core component of the coating thickness gauge. In order to meet the various requirements of our customers, probes for the most common applications are part of our range of products. For extraordinary measuring tasks, customer-made probes are available.

ElektroPhysik probes are the result of a combination of modern production technologies as well as of a surface treatment know-how from more than 60 years.

Intelligent probes

ElektroPhysik has developed a concept of "intelligent probes" allowing working with another probe connected to the same gauge if the measuring task alters.

The characteristic curve of the probe is stored in the probe connector and evaluated by the gauge's microprocessor. It is thus possible to program characteristic curves specified to the customer's application, e.g. special alloys, special geometries etc.

Wearing protection

For the production of its probes, ElektroPhysik uses precision production procedures from the field of horology. To ensure a long life, the probes are protected through construction features, thus avoiding traces of wear even after years of use. The use of materials such as e. q. rubies, hard metal or special alloys used in tool manufacture protects the contacting measuring pole against wear. The surface of the measuring pole is polished, thus offering to measure even on sensitive measuring objects without leaving any traces.

Newly developed universal probes

Especially for users taking measurements on steel and on non-ferrous metals, ElektroPhysik offers newly developed FN-universal probes which solve both measuring tasks with only one probe.

Why is calibration necessary?

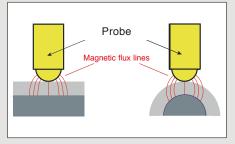
In order to adapt the probe to the individual measuring task in the best possible way, a calibration can be carried out. This calibration serves to compensate for influences exerted by the coating or the substrate as well as by the geometry of the object to be measured and improves the measuring accuracy.

Special features

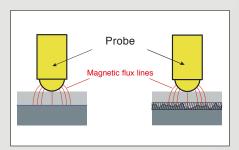
When taking measurements on curved surfaces, the probe can be adapted to the geometry of the object to be measured by means of calibration. The influence of the geometry on the measuring values is thus eliminated.

When taking measurements on rough surfaces, a special feature of the MiniTest serves to compensate for the higher measuring uncertainty which is due to physical reasons.

For measurements on surfaces with high temperature, special probes are available which can briefly be used for temperatures up to 350 °C.



Magnetic flux lines on curved surfaces



Magnetic flux lines on rough surfaces

MiniTest FN- und F-probes

Probe type	Measuring range/ Minimum area for measurement	Application	Illustrations
FN 1.6	01600 µm Ø 5 mm	non-magnetic coatings on steel and insulating coatings on non-ferrous metal, high resolution (0.1 $\mu\text{m})$ in the lower part of the measuring range	
FN 1.6 P	01600 μm Ø 30 mm	powder coatings before baking on steel and non-ferrous metal	
FN 1.6/90 FN 2/90	0 1600 µm Ø 5 mm 0 2000 µm Ø 5 mm	non-magnetic coatings on steel and insulating coatings on non-ferrous metal, especially appropriate for measurements in tubes and pipes or objects which are difficult to access, high resolution (0.1 µm) in the lower part of the measuring range	
F 05	0 500 μm Ø 3 mm	extremely thin metal, oxide or paint coatings on small steel objects high resolution (0.1 μm) in the lower part of the measuring range	
F 1.6	0 1600 µm Ø 5 mm	non-magnetic coatings on steel high resolution (0.1 $\mu m)$ in the lower part of the measuring range	
F 3	0 3000 µm Ø 5 mm	non-magnetic coatings on steel, thick paint and enamel coatings	
F 1.6/90 F 2/90	01600 μm Ø 5 mm 02000 μm Ø 5 mm	non-magnetic coatings on steel, especially appropriate for measurements in tubes and pipes or objects which are difficult to access; high resolution (0.1 μm) in the lower part of the measuring range	
F 10	0 10 mm Ø 20 mm	anticorrosive coatings in tanks and pipe construction, e.g. glass, plastics, rubber and concrete on steel	
F 20	0 20 mm Ø 40 mm	anticorrosive coatings in tanks and pipe construction, e.g. glass, plastics, rubber and concrete on steel	
F 50	050 mm Ø 300 mm	anticorrosive coatings in tanks and pipe construction, e.g. glass, plastics, rubber and concrete on steel, antinoise coatings	

MiniTest FN- and CN-probes

Probe type	Measuring range/ Minimum area for measurement	Application	Illustrations	
N 08 CR	080 µm Ø 5 mm	extremely thin chrome coatings on copper		
N 02	0200 µm Ø 2 mm	extremely thin insulating coatings, e.g. paint or anodising coatings on non-ferrous metal high resolution (0.1 μm) in the lower part of the measuring range		
N 1.6	01600 µm Ø5mm	thin insulating coatings, e.g. paint or anodising coatings on non-ferrous metal high resolution (0.1 μm) in the lower part of the measuring range		
N 1.6/90 N 2/90	0 1600 µm Ø 5 mm 0 2000 µm Ø 5 mm	thin insulating coatings, e.g. paint or anodising coatings on non-ferrous metal especially appropriate for measurements in tubes and pipes or objects which are difficult to access; high resolution (0.1 μm) in the lower part of the measuring range		
N 10	010 mm Ø 50 mm	insulating coatings, e.g. rubber, plastics, glass, on non-ferrous metal		
N 20	0 20 mm Ø 70 mm	insulating coatings, e.g. rubber, plastics, glass, Ø 70 mm on non-ferrous metal		
N 100	0100 mm Ø 200 mm	insulating coatings, e.g. rubber, plastics, glass, compounds etc., on non-ferrous metal		
CN 02	10200 µm Ø7mm	copper coatings on insulating substrates		

Accessories MiniTest



Technical data

Probes		Measuring range	Low range resolution	Guraranteed tolerance (of reading) ¹⁾	Minium radius of curvature (convex/concave)	Minimum area for measurement	Minimum substrate thickness	Dimension in mm	
Universal probes	FN 1.6		01600 µm	0.1 µm	± (1% + 1 μm)	1,5 mm / 10 mm	Ø5mm	F 0.5 mm/N 50µm	Ø 15x62
	FN 1.6 P		01600 µm	0.1 µm	± (1% + 1 μm)	only on flat surfaces	Ø 30 mm	F 0.5 mm/N 50µm	Ø 21x89
iversa	FN 1.6/90	Internal pipe probe	01600 μm	0.1 µm	± (1% + 1 μm)	flat / 6 mm	Ø5mm	F 0.5 mm/N 50µm	Ø 8x11x159
5	FN 2/90	Internal pipe probe	02000 μm	0.2 μm	± (1% + 1 μm)	flat / 6 mm	Ø5mm	F 0.5 mm/N 50µm	Ø 8x11x159
.u	F 05		0500 μm	0.1 µm	± (1% + 0,7 μm)	0,75 mm / 5 mm	Ø3mm	0.1 mm	Ø 12x49
Magnetic induction	F 1.6		0 1600 µm	0.1 µm	± (1% + 1 μm)	1,5 mm / 10 mm	Ø5mm	0.5 mm	Ø 15x62
jnetic	F 3*		03000 µm	0.2 μm	± (1% + 1 μm)	1,5 mm / 10 mm	Ø5mm	0.5 mm	Ø 15x62
Maç	F 1.6/90		0 1600 µm	0.1 µm	± (1% + 1 μm)	flat / 6 mm	Ø5mm	0.5 mm	Ø 8x11x159
	F 2/90		02000 µm	0.2 μm	± (1% + 1 μm)	flat / 6 mm	Ø5mm	0.5 mm	Ø 8x11x159
	F 10		010 mm	5 µm	± (1% + 10 μm)	5 mm / 16 mm	Ø 20 mm	1 mm	Ø 25x46
	F 20		020 mm	10 µm	± (1% + 10 μm)	10 mm / 30 mm	Ø 40 mm	2 mm	Ø 40x65
	F 50		050 mm	10 µm	± (3% + 50 μm)	50 mm / 200 mm	Ø 300 mm	2 mm	Ø 45x70
	NO8 CR		080 µm	0.1 µm	± (1% + 1 μm)	2.5 mm / 10 mm	Ø5mm	≥ 100 µm Cu	Ø 16x70
	N 02		0200 µm	0.1 μm	± (1% + 0,5 μm)	1 mm / 5 mm	Ø2mm	50 µm	Ø 16x70
	N 1.6		01600 µm	0.1 μm	± (1% + 1 μm)	1.5 mm / 10 mm	Ø5mm	50 µm	Ø 15x62
nciple	N 1.6/90	Internal pipe probe	01600 μm	0.1 μm	± (1% + 1 μm)	flat / 6 mm	Ø5mm	50 µm	Ø 8x11x159
Eddy current principle	N 2/90	Internal pipe probe	02000 µm	0.2 μm	± (1% + 1 μm)	flat / 6 mm	Ø5mm	50 µm	Ø 8x11x159
curre	N 10		010 mm	10 µm	± (1% + 25 μm)	25 mm / 100 mm	Ø 50 mm	50 µm	Ø 60x50
Eddy	N 20		020 mm	10 µm	± (1% + 50 μm)	25 mm / 100 mm	Ø 70 mm	50 μm	Ø 65x75
	N 100		0100 mm	100 μm	± (1% + 0,3 mm)	100 mm / flat	Ø 200 mm	50 μm	Ø 126x155
	CN 02 ²⁾	for Cu coatings on insulating substrates	10200 µm	0.2 μm	± (3% + 1μm)	only on flat surfaces	Ø7mm	at choice	Ø 17x80

 Power supply:
 1 x 9 V alkaline battery, AC adapter
 Ambient temperature:
 *Probes for high temperature:

 Battery life:
 10,000 measurements
 Gauge: 0...50 °C; Probe: -10 °C...70 °C, briefly 120 °C
 available (measuring ran conforming

 DIN 50981, 50982, 50984,
 Dimensions/weight: 150 mm x 82 mm x 35 mm/270 g
 available (measuring ran conforming

 \$tandards:
 ISO 2178, 2360/BS 5411/ASTM B499, B244 - CE
 *) A different copper composition of our standards and the object to be measured requires a reference standard to be prepared (e.g. cross cut)

*Probes for high temperatures up to 350 °C available (measuring range $0...2,000~\mu\text{m})$

Features

MiniTest Memory capacity	
Number of application memories	10
Number of batches for each application memory	10
Number of batches with individual value memories	max. 100
Total memory capacity for individual readings	10,000
Statistics	
From single values: $\overline{\mathbf{x}}$, σ , kvar, n, max., min.	
From single values: $\overline{\mathbf{x}}$, σ , kvar, n, max., min., CP, CPK	
Block statistics: $\overline{\mathbf{x}}$, σ , kvar, n, max., min.	
Block statistics: $\overline{\mathbf{x}}$, σ , kvar, n, max., min., CP, CPK	
From all subgroups (BATCH) in the same application (APPL)	
Print values and statistics separately to APPL-BATCH groups	
Display and print-out of date and time at the time of print-out and measurement (year, month, day, hour, minute)	
Calibration methods	
Calibration through a coating (CTC)	
Measurement on rough surfaces. The influence of roughness can nearly be eliminated	
OFFSET function adds or subtracts a constant value	
External function (trigger) to transfer readings to the memory	
Key lock to protect calibration	
Readings are saved during battery replacement	
Limit setting	
Measurements in microns or mils	
Continuous measuring mode with high speed readings to identify minimum and maximum values	
Selectable stabilising procedure in continuous mode for quick display (7 readings/s)	
Data transfer with floating or fixed decimal point	
Reading of measuring values without probe being connected	
Later print-out of single values of one batch	
Display of minimum value in continuous mode	

CHECK-LINE®-PRECISION QUALITY CONTROL INSTRUMENTS

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